Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/758,967	HAPKA ET AL.	
Examiner	Art Unit	
Phi D. A	3637	

SEARCHED					
Class	Subclass	Date	Examiner		
292	dig20	12/10/2006	PA		
	dig47*				
	dig46				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH (INCLUDING SEAF)
	DATE	EXMR
Gary Estremsky 292/	12/10/2006	PA
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